

Description

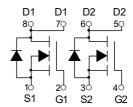
The HFDS8878 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

D2 D1 D1 G2 D1 S2 G1 S1

(SOIC-8)

General Features

 $V_{DS} = 30V \ I_D = 11.5A$ $R_{DS(ON)} < 30m\Omega \ @ V_{GS} = 10 \ V$ $R_{DS(ON)} < 42m\Omega \ @ V_{GS} = 4.5V$



Application

Battery protection

Load switch

Uninterruptible power supply

Dual N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
HFDS8878	SOP-8(SOIC-8)	HXY MOSFET	3000

Absolute Maximum Ratings@Tj=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _G s	Gate-Source Voltage	<u>+</u> 20	V
I _D @T _A =25°C	Drain Current, V _{GS} @ 4.5V ³	11.5	А
I _D @T _A =70°C	Drain Current, V _{GS} @ 4.5V ³	7.8	А
Ірм	Pulsed Drain Current ¹	42	Α
PD@TA=25°C	Total Power Dissipation	3.2	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rthj-a	Maximum Thermal Resistance, Junction- ambient ³	62.5	°C/W



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V,	-	-	1.0	μA
I _{GSS}	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	1.0	1.5	2.5	V
В	Static Drain-Source on-Resistance	V _{GS} =10V, I _D =10A	-	10	13	m0
$R_{DS(on)}$	note3	V _{GS} =4.5V, I _D =5A	-	16	22.5	mΩ
C _{iss}	Input Capacitance	\\ 45\\\\\ 0\\\	-	633	-	pF
Coss	Output Capacitance	V _{DS} =15V, V _{GS} =0V, f=1.0MHz	-	120	-	pF
C _{rss}	Reverse Transfer Capacitance	1-1.0101112	-	99	-	pF
Qg	Total Gate Charge	\/ -45\/ -40A	-	15	-	nC
Qgs	Gate-Source Charge	V_{DS} =15V, I_{D} =10A, V_{GS} =10V	-	4.7	-	nC
Q_{gd}	Gate-Drain("Miller") Charge	VGS-10V	-	3.6	-	nC
t _{d(on)}	Turn-on Delay Time		-	5	-	ns
t _r	Turn-on Rise Time	V_{DS} =30V, I_{D} =18A, R_{GEN} =3 Ω , V_{GS} =10V	_	8	-	ns
t _{d(off)}	Turn-off Delay Time		_	21	-	ns
t _f	Turn-off Fall Time		-	7	-	ns
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	11.5	Α
Ism	Maximum Pulsed Drain to Source Diode Forward Current		-	-	72	Α
M	Drain to Source Diode Forward	\/ -0\/ -10A		-	1.2	V
V_{SD}	Voltage	V _{GS} =0V, I _S =18A	_			
trr	Body Diode Reverse Recovery Time		-	7	-	ns
Orr	Body Diode Reverse Recovery	I _F =18A,dI/dt=100A/μs	-	5.9	-	nC
Qrr	Charge					

Note:

^{1.} The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper. 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

^{3.} The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=20A

^{4.} The power dissipation is limited by 150 $^{\circ}$ C junction temperature

^{5.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Electrical And Thermal Characteristics

=: 4 0 1 10 1 1 11

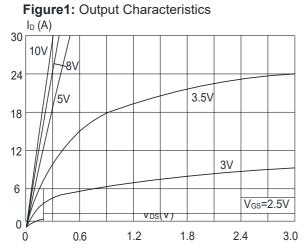


Figure 2: Typical Transfer Characteristics

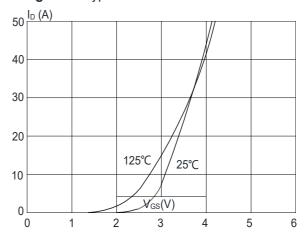


Figure 3:On-resistance vs. Drain Current RDS(ON) ($m\Omega$)

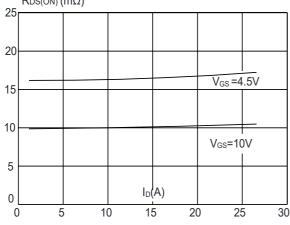


Figure 4: Body Diode Characteristics

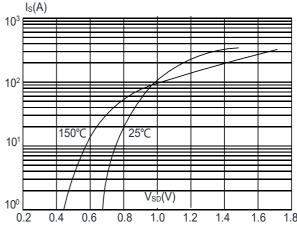


Figure 5: Gate Charge Characteristics

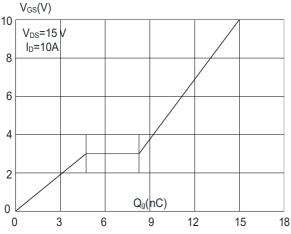


Figure 6: Capacitance Characteristics

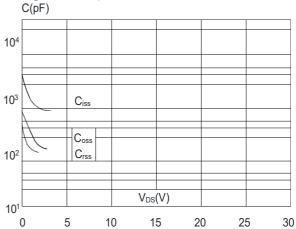




Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

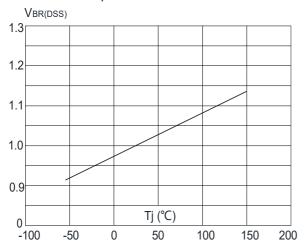


Figure 9: Maximum Safe Operating Area

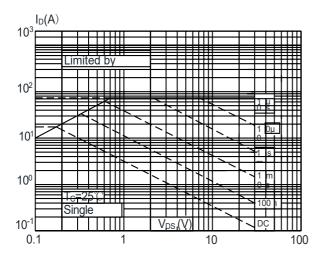


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

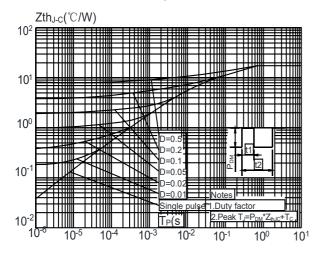


Figure 8: Normalized on Resistance vs. Junction Temperature

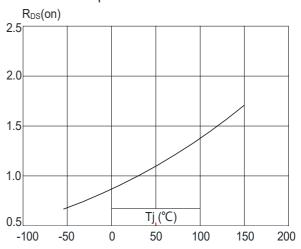
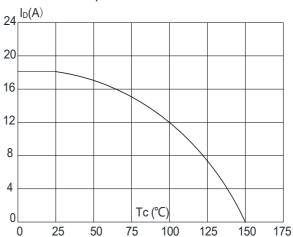
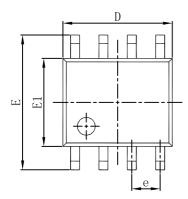


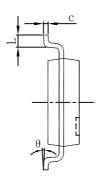
Figure 10: Maximum Continuous Drain Current vs. Case Temperature

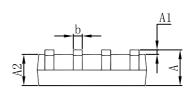




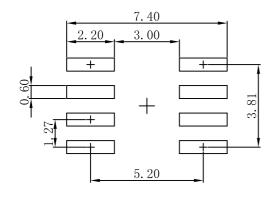
SOP-8(SOIC-8) Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
A	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
c	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
E	5.800	6. 200	0. 228	0.244	
E1	3.800	4.000	0.150	0. 157	
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



- Note: 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

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